



# TRENCHSTOP<sup>TM</sup> RC-Series for hard switching applications

## IGBT chip with monolithically integrated diode in packages offering space saving advantage

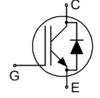
#### Features:

TRENCHSTOP<sup>™</sup> Reverse Conducting (RC) technology for 600V applications offering:

- $\bullet$  Optimised  $V_{\text{CEsat}}$  and  $V_{\text{F}}$  for low conduction losses
- Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Operating range of 1 to 20kHz
- Maximum junction temperature 175°C
- Short circuit capability of 5µs
- Best in class current versus package size performance

 $V_{CE}$ 

- Qualified according to JEDEC for target applications
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/



Package

Applications:
Motor drives

Chip Type

**Used for:** 

Discrete components and molded modules

**Die Size** 

Cilib Type	<b>V</b> CE	<b>/</b> Cn	Die Size	rackage			
IGC06R60DE	600V	8A	2.44 x 2.47 mm <sup>2</sup>	sawn on foil			
Mechanical Paramete	ers						
Raster size			2.44	x 2.47	2		
Emitter pad size			see chip	o drawing mm <sup>2</sup>			
Gate pad size			see chip	o drawing mm			
Area: total / active IGE	BT / active Dic	ode	6.026 / 3.	718 / 0.702			
Thickness			70				
Wafer size			2	00 mm			
Max.possible chips per wafer			4631				
Passivation frontside			Photoimide				
Pad metal			3200 nm AlSiCu				
Backside metal			Ni Ag –system				
Die bond			Electrically conductive epoxy glue and soft solder (temperature budget: 290°C for 1min. or 260°C for 1.5min.)				
Wire bond			Al, <350μm				
Reject ink dot size			Ø 0.65mm; max 1.2mm				
Storage environment	for original a sealed MBB		Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month				
	for open MB	B bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month				

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## **Maximum Ratings**

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, $T_{vj}$ =25 °C	V <sub>CE</sub>	600	V	
DC collector current, limited by $T_{\rm vj\;max}$	I <sub>C</sub>	1)	А	
Pulsed collector current, $t_p$ limited by $T_{vj \text{ max}}$	$I_{c,puls}$	24	А	
Gate emitter voltage	V <sub>GE</sub>	±20	V	
Junction temperature range	$T_{\rm vj,max}$	-40+175	°C	
Operating junction temperature	$T_{vj,op,max}$	-40+175	°C	
Short circuit data $^{2)3)}$ $V_{GE} = 15V$ , $V_{CC} = 400V$ , $T_{vj} = 150$ °C	tsc	5	μs	
Safe operating area IGBT <sup>2)3)</sup>	$I_{C,max} = 16A, V_{CE,max} = 600V, T_{vj,op} \le T_{vj,op,m}$			
Safe operating area Diode <sup>2)</sup>	I <sub>F,max</sub> = 16A, V <sub>R,max</sub> = 600V,			
	$P_{max}$ =6.6 kW , $T_{vj,op} \le T_{vj,op,max}$			

# Static Characteristics (tested on wafer), $T_{vj}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
. u.u.noto		Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	$V_{(BR)CES}$	$V_{\rm GE}$ =0V , $I_{\rm C}$ = 0.2 mA	600			
Collector-Emitter saturation voltage	V <sub>CEsat</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =8A		1.65	2.1	V
Diode Forward Voltage	V <sub>F</sub>	V <sub>GE</sub> =0V, I <sub>F</sub> =8A		1.7	2.1	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.15mA , $V_{\rm GE}$ = $V_{\rm CE}$	4.3	5	5.7	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{\text{CE}}$ =600V , $V_{\text{GE}}$ =0V			40	μA
Gate-Emitter leakage current	I <sub>GES</sub>	$V_{\text{CE}}$ =0V , $V_{\text{GE}}$ =20V			100	nA
Integrated gate resistor	r <sub>G</sub>			none		Ω

### **Dynamic Characteristics** (not subject to production test - verified by design / characterization), $T_{vi}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
raiametei	Syllibol	Conditions	min.	typ.	max.	Offic
Input capacitance	Cies	$V_{CE}=25V$ ,		775		
Output capacitance	Coes	$V_{GE}=0V$ ,		46		pF
Reverse transfer capacitance	Cres	f=1MHz		23		

depending on thermal properties of assembly
 not subject to production test - verified by design/characterization

<sup>3)</sup> allowed number of short circuits: <1000; time between short circuits: >1s





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#### **Further Electrical Characteristic**

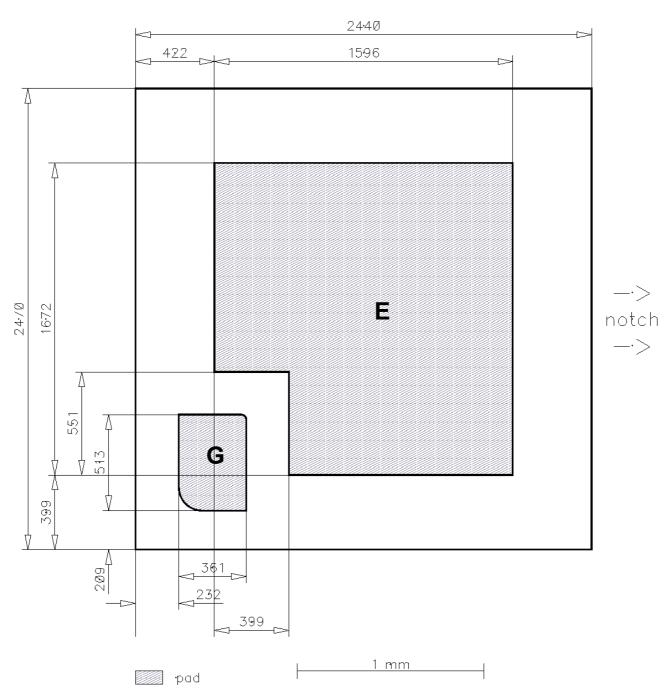
Switching characteristics and thermal properties are depending strongly on package design and mounting technology and can therefore not be specified for a bare die.

Further technical information about the performance of this chip in package t.b.d. is given exemplarily at www.infineon.com/igbt. The chip qualification is independent of the qualification which is performed for the Discretes.

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## **Chip Drawing**

Die-Size 2440 ·um x 2470 um



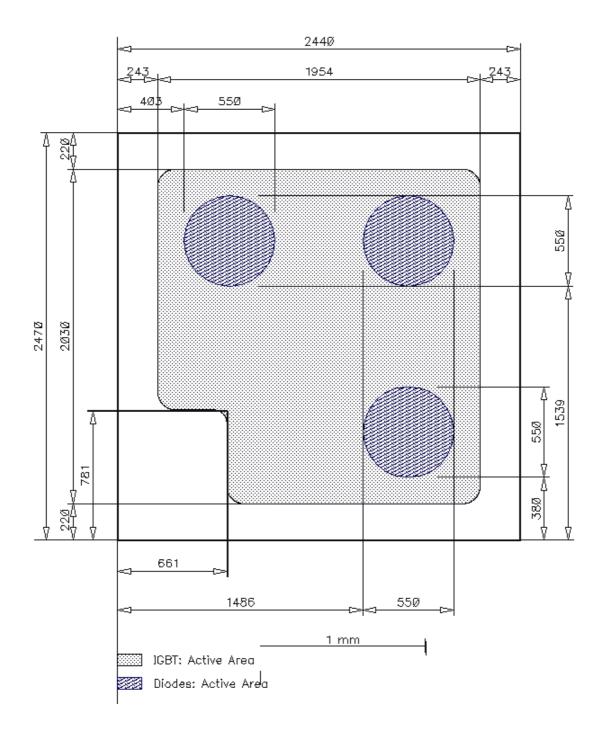
**E** = Emitter

**G** = Gate



### **Chip Drawing active areas**

Die-Size 2440 um x 2470 um







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Description
AQL 0,65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883

#### **Revision History**

Version	Subjects (major changes since last revision)	Date

Published by Infineon Technologies AG 81726 Munich, Germany © 2013 Infineon Technologies AG All Rights Reserved.

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